



Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10627881	SAED, ARYAN
	Examiner Lee, Siu M	Art Unit 2611

Notes	Date	Examiner
EAST	9/25/2006	Siu Lee
IEEE	9/29/2006	Siu Lee
Discuss the application with Chieh Fan	9/27/2006	Siu Lee
U.S. Patent and Trademark Office		Part of Paper No.:

<p>Searched</p> 	<p>Application/Control No.</p> <p>10627881</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>SAED, ARYAN</p>
	<p>Examiner</p> <p>Lee, Siu M</p>	<p>Art Unit</p> <p>2611</p>

Class	SubClass	Date	Examiner
375	146,221,222,226,268,271,295,300,302,296,232,233	9/28/2006	Siu Lee
330	149,151,52,124R,295,136,2	9/28/2006	Siu Lee
455	114.3,163.1,125	9/28/2006	Siu Lee
U.S. Patent and Trademark Office		Part of Paper No.:	